

Notice of References Cited	Application/Control No. 09/844,780	Applicant(s)/Patent Under Reexamination KAIMAI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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*	N	EP0933418 A2	04-1999	European	Kaimai et al.	
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NON-PATENT DOCUMENTS

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